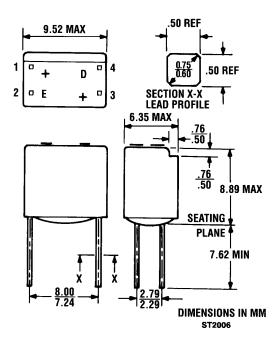


H24A1 H24A2

PACKAGE DIMENSIONS



DESCRIPTION

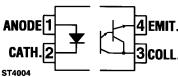
The H24A series consists of a gallium arsenide infrared emitting diode coupled with a silicon phototransistor. The devices are housed in a low-cost plastic package with lead spacing compatible with a dual in-line package.

FEATURES

- 4-pin configuration
- Small package size and low cost
- UL recognized-file E51868

APPLICATIONS

- Digital logic inputs
- Microprocessor inputs
- Industrial controls



Equivalent Circuit

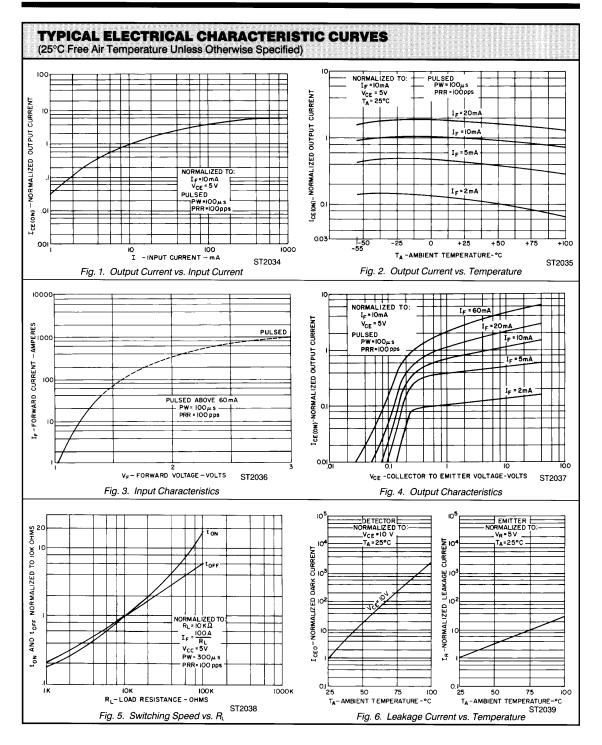


ELECTRICAL CHARACTERISTICS (25°C Temperature Unless Otherwise Specified)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
INPUT DIODE						
Forward voltage	$V_{\scriptscriptstyle F}$	_		1.7	V	I _F =60 mA
Reverse current	l _R			1	μA	V ₈ =3 V
Reverse breakdown voltage	V _{(BR)R}	4		<u> </u>	V	$I_{\rm H}=10~\mu{\rm A}$
Capacitance	C,	_	30		pF	V=0, f=1 MHz
OUTPUT DETECTOR Breakdown voltage Collector to emitter	BV _{c∈o}	30			٧	I _c =1 mA, I _F =0
Breakdown voltage Emitter to Collector	BV _{ECO}	7			V	I _c =100 μA, I _F =0
Collector dark current	I _{CEO}		5	100	nA	$V_{CE} = 10 \text{ V}, I_F = 0$
Capacitance	C _{CE}		3.3		pF	V _{CE} =5 V, f=1 MHz

TRANSFER CHAI	RACTERIST	rics				
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
DC CURRENT TRANSFE	R RATIO					
H24A1	lc	10.0			mA	I _F =10 mA, V _{CE} =10 V
H24A2	Ic	2.0			mA	$I_F = 10 \text{ mA}, V_{CE} = 10 \text{ V}$
Saturation voltage	V _{CE(SAT)}	<u> </u>	0.1	0.4	V	$I_F = 10 \text{ mA}, I_C = 0.5 \text{ mA}$
Turn-on time	t _{on}		9		μS	$I_c=2$ mA, $V_{ce}=10$ V, $R_c=100$ Ω
Turn-off time	t _{off}		4		μS	$I_F=2$ mA, $V_{CE}=10$ V, $R_L=100$ Ω
Turn-on time	t _{on}		6.5		μS	$I_F=10$ mA, $V_{CE}=5$ V, $R_L=10$ K Ω
Turn-off time	t _{off}		165		μS	$I_F=10$ mA, $V_{CE}=5$ V, $R_L=10$ K Ω

CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
Surge isolation voltage	V _{iso}	6000			V _{Peak}	1 Minute
Steady-state isolation voltage	V _{iso}	5300			V _{RMS}	1 Minute
Isolation resistance	R _{iso}	1011		-	ohms	V _{I-0} =500 VDC
Isolation capacitance	C _{iso}		0.5		pF	V _{.⊙} =0, f=1 MHz





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